APPLICABLE STAN Operating Ter		mooratura			Storage Te		emperature	nperature				
	Range		-25 C 10 + 105 C ->			Range			-10°C to +60°C			
Rating	Volta	ge	AC 1000V , DC 15	007				-				
	Current		310A			Applicable Cable			150mm² (250/300N	ICM)		
			SPEC	CIFICATI	IONS	S						
	ITEM		TEST METHOD				RE	QUIR	EMENTS	QT	Α	
CONST	RUCTION											
	xamination		d visually and with a measur	ring instrum	ent.	Accord	ling to the d	Irawin	n	Х	>	
Marking		Confirme				/100010			·9.	Х)	
	RICAL CHAP	RACTER	ISTICS									
Contact Resistance		Measured at DC 1A.				0.1mΩ MAX.				Х	-	
Insulation Resistance		Measured at DC 500V.				1000MΩ MIN.				Х	-	
Voltage Proof		AC 5000V applied for 1min.				No flashover or breakdown.				x		
		(JIS C 8201)									-	
Short-Time Withstand Current Test		Measured at 18000A applied for 1s.				Contac	t Resistance	ce: 0.1	15 mΩ MAX.	х	_	
MECHANICAL CHAI					Contact Resistance: 0.15 mΩ MAX. X							
месна	NICAL CHA	RACTER	RISTICS									
Crimp Contact Insertion and Extraction Forces		Measured with an applicable connector.				Insertion Force: 280N MAX. Extraction Force: 250N MAX.				х	_	
									ng damage, cracks, or	+	_	
							o runction in					
Mechanica	al Operation	Contact Inserted and Extracted 50 times.				2) Co	ontact Resis	stance	e: 0.15mΩ MAX.	х	-	
						,	sertion Force: 280N MAX. traction Force: 250N MAX.					
		Frequenc	y: 10 Hz to 55 Hz			-, LA		100.2	50N M/AA.	-	-	
Vibration		Single amplitude: 0.75 mm				1) No	electrical o	discor	nuity of 10us			
		Performed two hours in each of three mutually				 No electrical disconuity of 10µs. No damage, cracks, or looseness of parts 					-	
			cular directions. I-1344 Method 2005, Condit	tion 2)			-					
		(
<u>.</u>			ion: 500 m/s ²			1) No	electrical o	discor	nuity of 10µs.			
Shock		Half sine wave pulses of 11 ms. Performed five times both ways in each of three				2) No damage, cracks, or looseness of parts.				. x	-	
			perpendicular directions.	ich of three								
Contact Dr	stantian Force	A 427N	sulling force was applied to	o the conne	ection	No dor						
Contact Retention Force		side. (NECA C 2811)				No damage.				Х	-	
ENVIRC	DNMENTAL	CHARA	CTERISTICS									
Damp Hea	*	Subjected	d to 40±2°C, at a humidity 9	0% to 95%,	for				ce: 20MΩ MIN. 5000V applied for 1mir			
(Steady State)		96 hours. Returned to room temperature and normal humidity, and removed of any water. (NECA C 2811)			1111di	No flashover or breakdown.				· X	-	
	-	numaty,	and removed of any water.		'				s, or looseness of parts			
			Subjected to -25±3°C for 2 hours. Returned to room			 Insulation Resistance: 20MΩ MIN. Voltage Proof: AC 5000V applied for 1min. 						
Heat and C	Cold Resistance	temperature for 1 hour. Subjected to 70±3°C for 2 hours . (NECA C 2811)			2	No flashover or breakdown.				· x	-	
						3) No	o damage, o	cracks	s, or looseness of parts		_	
		-	to the following cycle 192 t	times with 3		1) 0-	ntact Basis	tona				
Ageing Test		applied. Subjected	to 40±3°C for 10 minutes,	cooled to 30		,		sistance: 0.15mΩ MAX. e, cracks, or looseness of parts		х	-	
			or 10 minutes. (JIS C 8201)		-	,			,			
COU	JNT D	ESCRIPTIC	IPTION OF REVISIONS DESIG		DESIG	SNED			CHECKED		٩ΤΕ	
2 1			DIS-C-00010297			DS. MATSUNE			KI. NAGANUMA		2022	
/~\ !	Notes											
<u> </u>	(1) Above specifications show the values in assembled condition with					APPROVED TP. KOMATSU		IF. NUMAISU	20200304			
Notes	بالبار مثل منصوص	applicable crimp contacts.					CHECKED TP. KOMATSU					
Notes (1)				(2) Including temperature rise caused by current carrying.					DESIGNED EK. KIDO			
Notes (1)		perature ris	e caused by current carrying	g.			DESIGNE	D	EK. KIDO	2020	0022	
Notes (1) (2)	Including tem			g.								
Notes (1) (2) Unless oth	Including temp	l, refer to IE	C 60512 (JIS C 5402).				DRAWN		EK. KIDO	2020	0022	
Notes (1) (2) Unless oth	Including temp erwise specified Qualification Te	l, refer to IE st AT:Ass	C 60512 (JIS C 5402). urance Test X:Applicable T	est				1	EK. KIDO ELC-385256-(2020	0022	
(1) (2) Unless oth	Including temp erwise specified	l, refer to IE st AT:Ass	C 60512 (JIS C 5402).	est	DF		DRAWN	1	EK. KIDO	2020	0022	